Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/840,060	DEAK ET AL.	
Examiner	Art Unit	
Rita Mitra	1653	

SEARCHED					
Class	Subclass	Date	Examiner		
536	23.1 24.1 24.31	5/25/2006	RM		
435	6	5/25/2006	RM		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT STN: BIOSIS, CAPLUS, EMBASE, MEDLINE, SCISEARCH	5/25/2006	RM	
STIC conducted sequence search for SEQ ID NO: 142	5/25/2006	RM	
Inventors search done	5/25/2006	RM	
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